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Features:

- TID Capable to 100Krad (SI)/cm2 ELDRS (0.1rad/s)
- Neutron capable to 1E12 neutrons (14MeV)
- TX & TXV Processing available to MIL-STD-19500
- 1 KV electrical Isolation

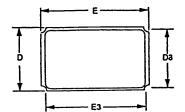


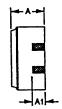
Description:

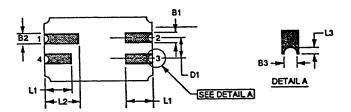
This device is similar to Optek's 4N series of optoisolators with exception of the die. TX & TXV processing is per MIL-PRF-19500 and can be modified per customer SCDs. Each device consists of a IRLED & NPN transistor mounted in a hermetic 4 pin LCC SMD.

Applications:

Circuit electrical isolation in space applications such as satellites, launchers, space vehicles and planetary rovers







Dimensions					
	Incl	hes	Millimeters		
Ltr	Min	Max	Min	Max	
Α	.061	.075	1.55	1.90	
A1	.026	.034	0.66	0.88	
B1	.022	.028	0.56	0.71	
B2	.072 Ref		1.83 Ref		
В3	.006	.022	0.15	0.56	
D	.145	.155	3.68 1.14	3.93	
D1	.045	.055		1.39 3.93	
D3	-	.155	1		
E	.215	.225	5.46	5.71	
E3	-	.225	-	5.71	
L1	.032	.048	0.81	1.22	
L2	.072	.088	1.83	2.23	
L3	.003	.007	0.08	0.18	
N	4				
ND	2				
NE	0				

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Electrical Specifications

Absolute Maximum Ratings (T_A = 25° C unless otherwise noted)

Storage Temperature Range	-55° C to +150° C
Operating Temperature Range	-55° C to +150° C
Input-to-Output Isolation Voltage	± 1.00 kVDC ⁽¹⁾
Lead Soldering Temperature (TO-78 Metal Can) [1/16 inch (1.6 mm) from case for 5 seconds with soldering iron]	260° C ⁽²⁾
Soldering Temperature (SMD) Vapor Phase Reflow for 30 seconds	215° C

Input Diode (LED)

Forward DC Current (65° C or below)	40 mA
Reverse Voltage	2 V
Power Dissipation	60 mW ⁽³⁾

Output Phototransistor:

Continuous Collector Current	50 mA
Collector-Emitter Voltage	40 V
Power Dissipation	300 mW ⁽⁴⁾

Notes:

- 1. Measured with input leads shorted together and output leads shorted together.
- 2. RMA flux is recommended.
- 3. Derate linearly 1.0 mW/° C above 65° C.
- 4. Derate linearly 3.0 mW/° C above 25° C.

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Performance

Electrical Characteristics (T_A = 25°C unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
Input Dioc	de					
V_{F}	Forward Voltage	0.80 1.00 0.70	- - -	1.70 1.9 1.50	V	I _F = 10.0 mA I _F = 10.0 mA, T _A = -55° C I _F = 10.0 mA, T _A = 125° C
I _R	Reverse Current	-	-	100	μΑ	V _R = 2.0 V
Output Ph	nototransistor					
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage	40	-	-	V	I _C = 1.0 mA, I _B = 0, I _F = 0
V _{(BR)EBO}	Emitter-Collector Breakdown Voltage	7	-	-	V	I _E = 100 μA, I _C = 0, I _F = 0
I _{C(OFF)} ¹	Collector-Emitter Dark Current	-	-	100	nA	V _{CE} = 20 V, I _B = 0, I _F = 0
I _{C(OFF)} ²	Collector-Emitter Dark Current	-	-	100	μΑ	V _{CE} = 20 V, I _B = 0, I _F = 0, T _A = 100° C
Coupled						
I _{C(ON)}	On-State Collector Current	1 15 10 15 2.8 2.0	- - - -		mA	$\begin{split} I_F &= 1.0 \text{ mA, } V_{CE} = 1.0 \text{ V, } I_B = 0 \\ I_F &= 15.0 \text{ mA, } V_{CE} = 1.0 \text{ V, } I_B = 0 \\ I_F &= 10.0 \text{ mA, } V_{CE} = 5.0 \text{ V, } I_B = 0 \\ I_F &= 15.0 \text{ mA, } V_{CE} = 5.0 \text{ V, } I_B = 0 \\ I_F &= 2.0 \text{ mA, } V_{CE} = 5.0 \text{ V, } I_B = 0, T_A = -55^{\circ} \text{ C} \\ I_F &= 2.0 \text{ mA, } V_{CE} = 5.0 \text{ V, } I_B = 0, T_A = 100^{\circ} \text{ C} \end{split}$
V _{CE(SAT)}	Collector-Emitter Saturation Voltage	-	-	0.30	V	$I_F = 20.0 \text{ mA}, I_C = 10.0 \text{ mA}, I_B = 0$
R _{IO}	Resistance (Input-to-Output)	10 ¹¹	-	-	Ω	V _{I-O} = ± 1000 VDC ⁽¹⁾
C _{IO}	Capacitance (Input-to-Output)	-	-	5	pF	V _{I-O} = 0 V, f = 1.0 MHz ⁽¹⁾
T_R,T_F	Rise and Fall Time	-	-	20	μs	V_{CC} = 10.0 V , I_F = 10.0 mA, R_L = 100 Ω

Notes:

 ${\bf 1.} \quad {\bf Measured \ with \ input \ leads \ shorted \ together \ and \ output \ leads \ shorted \ together.}$

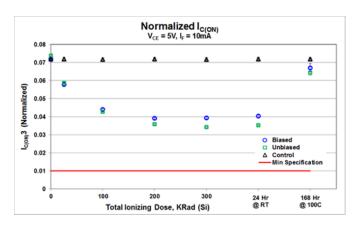
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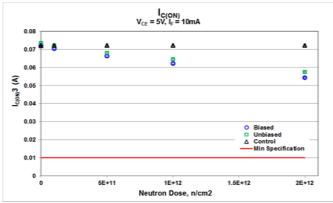
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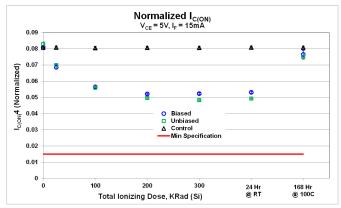


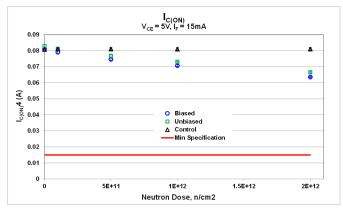
Radiation Test Standards

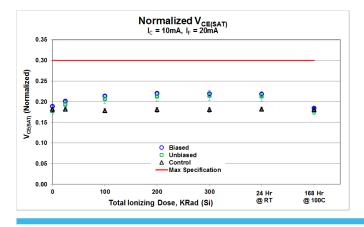
- Total Ionizing Dose: MIL-STD-883 Method 1019.7 and ASTM F1892-06 (0.1rad (si)/s) dose rate
- Neutron: MIL-STD-883 Method1017.2 and ASTM Designation: E 772—94
- Full Radiation report available

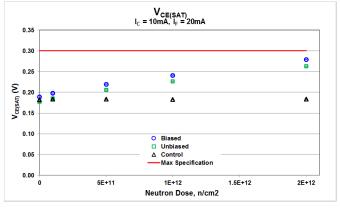












General Note

TT Electronics reserves the right to make changes in product specification without notice or liability. All information is subject to TT Electronics' own data and is considered accurate at time of going to print.

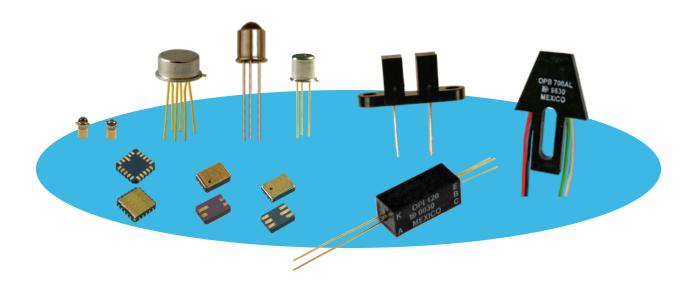
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Packaging

Package styles available:

Radiation testing was in a TO-78 can; functional & radiation samples can be supplied in discrete pairs such as, "pills" or TO-46 / TO-18 metal cans, 4 & 6 pin Hermetic Ceramic LLC, high voltage assemblies like the OPI120 and OPI150 hermetic high voltage isolators and more.



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Issue	Change Description	Approval	Date
А	Initial Preliminary Release	R. Bailey	3-23-16